AUTOMOTIVE CURRENT TRANSDUCER OPEN LOOP TECHNOLOGY
HC5FL 900-S/SP1

Introduction

The HC5F family is for the electronic measurement of DC, AC or pulsed currents in high power and low voltage automotive applications with galvanic separation between the primary circuit (high power) and the secondary circuit (electronic circuit). The HC5F family gives you the choice of having different current measuring ranges in the same housing.

Features

- Open Loop transducer using the Hall effect
- Low voltage application
- Unipolar +5 V DC power supply
- Primary current measuring range up to ±900 A
- Maximum RMS primary current limited by the busbar, the magnetic core or the ASIC temperature T < +150 °C
- Operating temperature range: −40 °C < T < +125 °C
- Output voltage: full ratiometric (sensitivity and offset)
- High speed transducer.

Advantages

- Good accuracy
- Good linearity
- Low thermal offset drift
- Low thermal sensitivity drift.

Automotive applications

- Electrical Power Steering
- Starter Generators
- Converters.

Principle of HC5F Family

The open loop transducers use a Hall effect integrated circuit. The magnetic flux density B, contributing to the rise of the Hall voltage, is generated by the primary current I_P to be measured. The current to be measured I_P is supplied by a current source i.e. battery or generator (Figure 1).
Within the linear region of the hysteresis cycle, B is proportional to:

$$B\ (I_P) = a \times I_P$$

The Hall voltage is thus expressed by:

$$U_{Hall} = (c_{Hall} / d) \times I_{Hall} \times a \times I_P$$

Except for I_P, all terms of this equation are constant. Therefore:

$$U_{Hall} = b \times I_P$$

a	constant
b	constant
c_{Hall}	Hall coefficient
d	thickness of the Hall plate
I_{Hall}	current across Hall plates

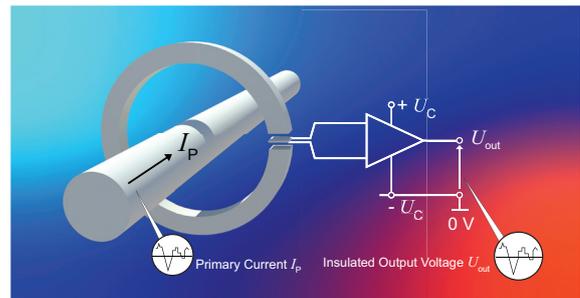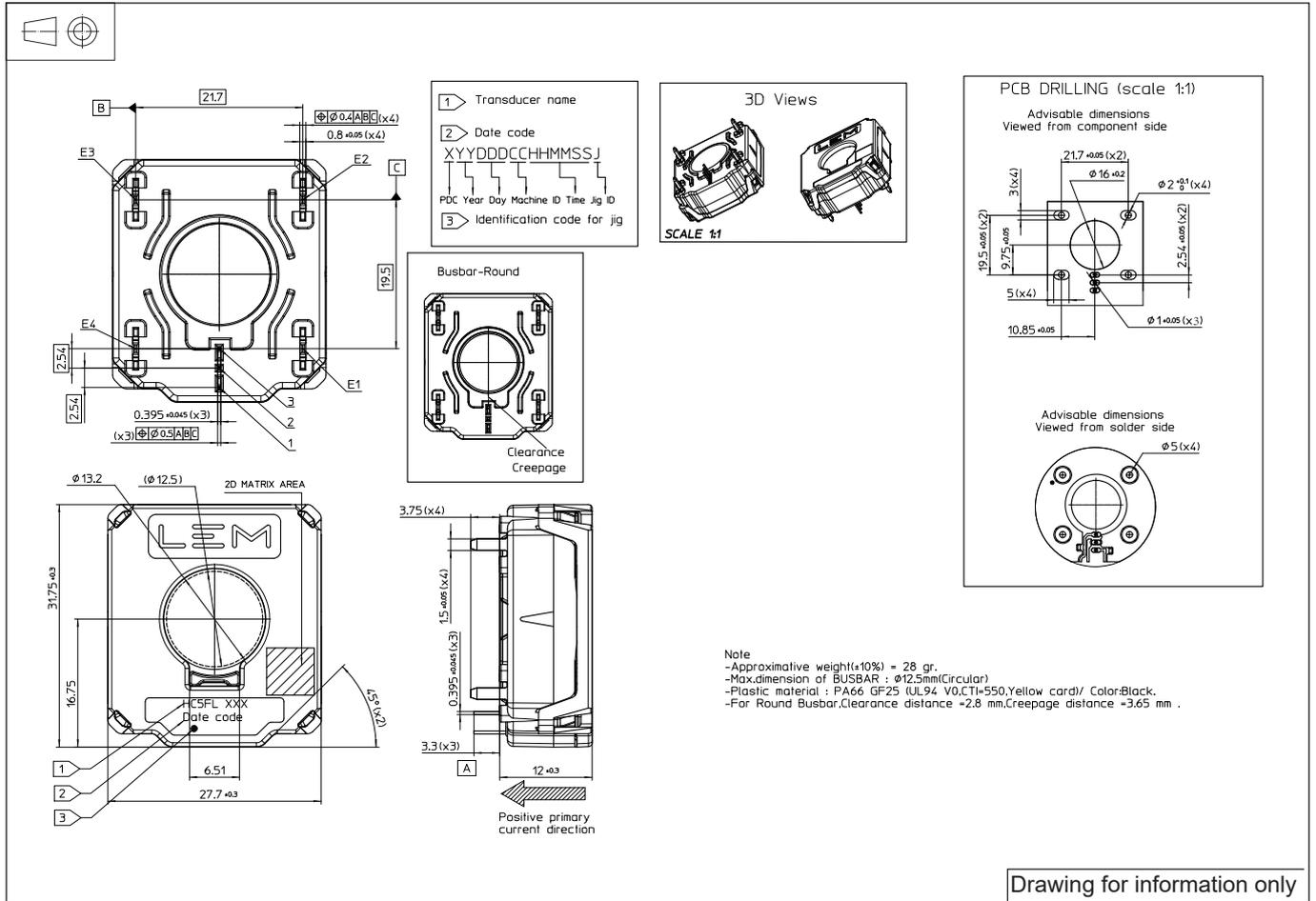The measurement signal U_{Hall} is amplified to supply the user output voltage or current.

Fig. 1: Principle of the open loop transducer.

Dimensions (in mm)

Note
- Approximative weight(±10%) = 28 gr.
- Max.dimension of BUSBAR : Ø12.5mm(Circular)
- Plastic material : PA66 GF25 (UL94 V0,CTI=550,Yellow card)/ Color:Black.
- For Round Busbar,Clearance distance =2.8 mm,Creepage distance =3.65 mm .
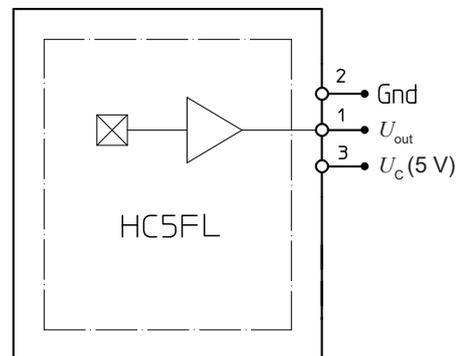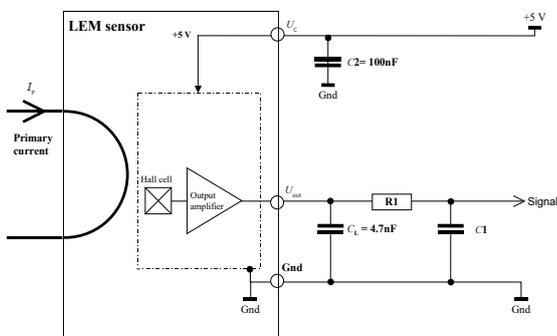
Drawing for information only

Mounting recommendation

- Connector type   None
- Assembly torque max   None
- Soldering profile   See page 8

Remarks

- $I_P = \left(\dfrac{5}{U_C} \times U_{out} - U_O \right) \times \dfrac{1}{S}$ with S in (V/A)

- $U_{out} > U_O$ when I_P flows in the positive direction (see arrow on drawing)

- R1, C1: low pass filter (optional).

Electronic schematic

Absolute ratings (not operating)

Parameter	Symbol	Unit	Specification			Conditions
			Min	Typical	Max	
Maximum supply voltage	$U_{C\,max}$	V			7	not operating
					6.5	Exceeding this voltage may temporary reconfigure the circuit until the next power-on
Ambient storage temperature [3]	$T_{A\,st}$	°C	−40		125	
Electrostatic discharge voltage	$U_{ESD\,HBM}$	kV			6	ISO 10605
Maximum admissible vibration (random)	γ_{max}	m·s^{-2}		96.6		
RMS voltage for AC insulation test, 50 Hz, 1 min	U_d	kV			2.5	50 Hz, 1 min, ISO 16750-2
Insulation resistance	R_{INS}	MΩ	500			
Creepage distance	d_{Cp}	mm		3.65		
Clearance	d_{Cl}	mm		2.8		
Comparative tracking index	CTI	V		PLC 1		

Operating characteristics in nominal range (I_{PN})

Parameter	Symbol	Unit	Specification			Conditions
			Min	Typical	Max	
Electrical Data						
Supply voltage [1]	U_C	V	4.9	5.0	5.1	
Ambient operating temperature	T_A	°C	−40		125	
Output voltage (Analog)	U_{out}	V	$U_{out} = (U_C/5) \times (U_O + S \times I_P)$			
Offset voltage	U_O	V		2.5		@ U_C = 5 V
Current consumption	I_C	mA		6.5	8	@ U_C = 5 V, T_A = 25 °C
Load resistance	R_L	KΩ	10			
Load capacitance	C_L	nF		4.7		
Performance Data [1]						
Ratiometricity error	ε_r	%		0.5		
Sensitivity error	ε_S	%		±1.5		@ T_A = 25 °C
Electrical offset voltage	U_{OE}	mV		±2.5		@ T_A = 25 °C, @ U_C = 5 V
Magnetic offset voltage	U_{OM}	mV		±2.5		@ T_A = 25 °C, @ U_C = 5 V, after ±I_P
Average temperature coefficient of U_{OE}	$TCU_{OE\,AV}$	mV/°C		±0.1		@ −40 °C < T < 125 °C
Average temperature coefficient of S	TCS_{AV}	%/°C		±0.02		@ −40 °C < T < 125 °C
Linearity error	ε_L	% I_P		±0.5		@ −800 A ≤ I_{PM} ≤ 800 A
Linearity error	ε_L	% I_P		±1.5		@ −900 A ≤ I_{PM} < −800 A @ 800 A < I_{PM} ≤ 900 A
Delay time to 80 % to the final output value for I_{PN} step	$t_{D\,80}$	µs		8		di/dt = 100 A/µs
Frequency bandwidth [2]	BW	kHz		40		@ −3 dB
Phase shift	$\Delta\varphi$	°		−4	0	@ DC to 1 kHz
Minimum output voltage	$U_{out\,min}$	V			0.25	@ U_C = 5 V
Maximum output voltage	$U_{out\,max}$	V	4.75			@ U_C = 5 V
Peak-to-peak noise voltage	$U_{no\,pp}$	mV		20		DC to 1 MHz

Notes:

[1] The output voltage U_{out} is fully ratiometric. The offset and sensitivity are dependent on the supply voltage U_C relative to the following formula:

$$I_P = \left(\frac{5}{U_C} \times U_{out} - U_O \right) \times \frac{1}{S} \text{ with } S \text{ in (V/A)}$$

[2] Small signal only to avoid excessive heating of the busbar, the magnetic core and the ASIC

[3] Busbar temperature must be below 150 °C.

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Parameter	Symbol	Unit	Specification			Conditions
			Min	Typical	Max	
			Electrical Data			
Primary current, measuring range	I_{PM}	A	−900		900	
Sensitivity	S	mV/A		2.22		@ U_c = 5 V

Total Error

HC5FL 900-S/SP1: Absolute Total Error ε_{tot} @ U_C = 5 V
specified @ 3 sigma
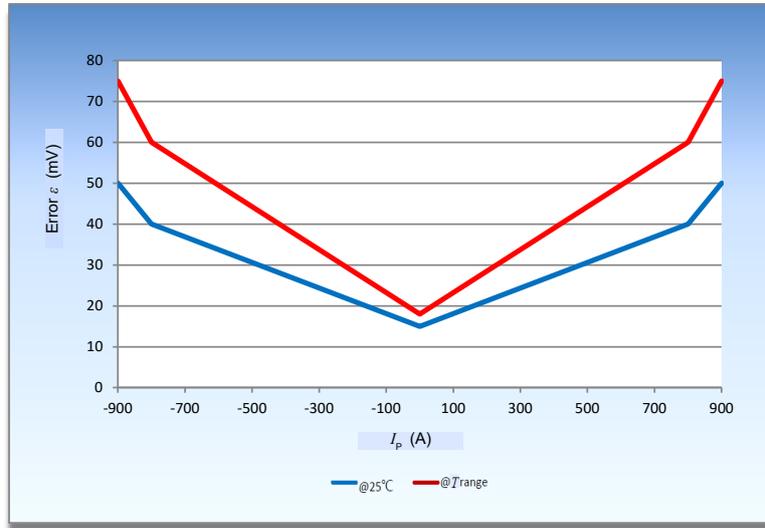
Primary current I_P (A)	Total Error @ 25 °C (mV)	Total Error @ T range (mV)
−900	±50	±75
−800	±40	±60
0	±15	±18
800	±40	±60
900	±50	±75

PERFORMANCES PARAMETERS DEFINITIONS

Primary current definition:

① Primary current nominal ($I_{P\,N}$)

② Primary current, measuring range ($I_{P\,M}$)
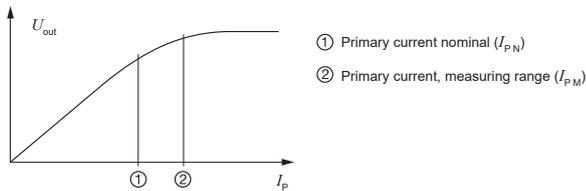
Definition of typical, minimum and maximum values:

Minimum and maximum values for specified limiting and safety conditions have to be understood as such as values shown in "typical" graphs. On the other hand, measured values are part of a statistical distribution that can be specified by an interval with upper and lower limits and a probability for measured values to lie within this interval. Unless otherwise stated (e.g. "100 % tested"), the LEM definition for such intervals designated with "min" and "max" is that the probability for values of samples to lie in this interval is 99.73 %. For a normal (Gaussian) distribution, this corresponds to an interval between −3 sigma and +3 sigma. If "typical" values are not obviously mean or average values, those values are defined to delimit intervals with a probability of 68.27 %, corresponding to an interval between −sigma and +sigma for a normal distribution. Typical, minimum and maximum values are determined during the initial characterization of a product.

Output noise voltage:

The output voltage noise is the result of the noise floor of the Hall elements and the linear amplifier.

Magnetic offset:

The magnetic offset is the consequence of an any current on the primary side. It's defined after a stated excursion of primary current.

Linearity:

The maximum positive or negative discrepancy with a reference straight line $U_{out} = f(I_P)$.
Unit: linearity (%) expressed with full scale of $I_{P\,N}$.
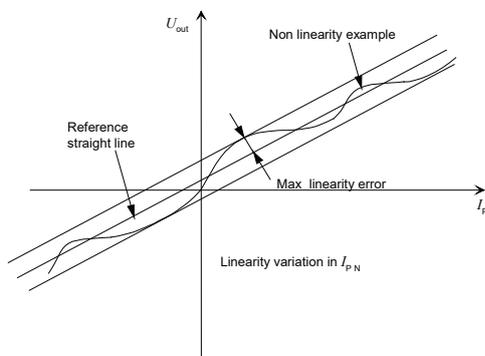
Delay time $t_{D\,80}$:

The time between the primary current signal ($I_{P\,N}$) and the output signal reach at 80 % of its final value.
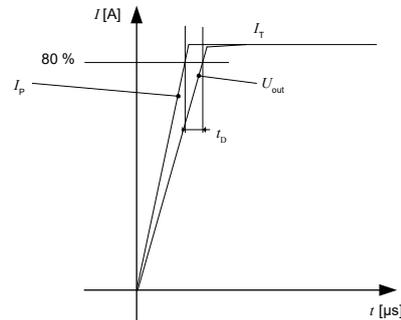
Sensitivity:

The transducer's sensitivity S is the slope of the straight line $U_{out} = f(I_P)$, it must establish the relation:

$$U_{out}(I_P) = U_C/5\,(S \times I_P + U_O)$$

Offset with temperature:

The error of the offset in the operating temperature is the variation of the offset in the temperature considered with the initial offset at 25 °C.

The offset variation $I_{O\,T}$ is a maximum variation the offset in the temperature range:

$$I_{O\,T} = I_{O\,E}\,\max - I_{O\,E}\,\min$$

The offset drift $TCI_{O\,E\,AV}$ is the $I_{O\,T}$ value divided by the temperature range.

Sensitivity with temperature:

The error of the sensitivity in the operating temperature is the relative variation of sensitivity with the temperature considered with the initial offset at 25 °C.

The average temperature coefficient of sensitivity TCS_{AV}, S_T is the maximum temperature variation of S (in ppm or %) of the sensitivity in the temperature range:

S_T = (Sensitivity max − Sensitivity min) / Sensitivity at 25 °C.
The average temperature coefficient of sensitivity TCS_{AV} is the S_T value divided by the temperature range.
Deeper and detailed info available in our LEM technical sales offices (www.lem.com).

Offset voltage @ I_P = 0 A:

The offset voltage is the output voltage when the primary current is zero. The ideal value of U_O is $U_C/2$. So, the difference of $U_O - U_C/2$ is called the total offset voltage error. This offset error can be attributed to the electrical offset (due to the resolution of the ASIC quiescent voltage trimming), the magnetic offset, the thermal drift and the thermal hysteresis. Deeper and detailed info available in our LEM technical sales offices (www.lem.com).

Environmental test specifications:

Refer to LEM GROUP test plan laboratory CO.11.11.515.0 with "Tracking_Test Plan_Auto" sheet.

Environmental test specifications plan:

| Name	Standard
THERMAL FATIGUE	
Ageing 85 °C / 85 % HR / 1000 h	JESD 22-A101 (2009)
Power temperature cycle test −40 °C / 125 °C / 240 h	ISO 16750-4 (04.2010)
Thermal shocks −40 °C / 125 °C / 1000 h	ISO 16750-4 (04.2010)
High temperature storage at 125 °C / 1000 h	ISO 16750-4 (04.2010)
Low temperature storage at −40 °C / 1000 h	ISO 16750-4 (2006)
MECHANICAL FATIGUE	
Sinusoidal vibration test	
Random Vibration test	
Mechanical Shocks	ISO 16750-3 (12 2012)
Free Fall	
ELECTRICAL TESTS	
Phase delay	--
Output noise	--
di/dt (100 A/µs)	--
du/dt (4 kV A/µs to 2 kV)	--
Withstand voltage (2500 V RMS −50 Hz / 1 min)	ISO 16750-2 (2012)
Insulation resistance (500 V dc / 1 min)	ISO 16750-2 (2012)
EMC TESTS	
Radiated Emissions: Absorber Lined Shielded Enclosure (ALSE)	IEC CISPR25(2016)
Radiated Immunity: Bulk Current Injection (BCI)	ISO 11452-4(2020)
Radiated Immunity: Anechoic chamber	ISO 11452-2(2019)
Resistance to Electrostatic Discharge Voltage	ISO 10605 (2008)

Soldering recommendations:

1 - Iron Soldering plated-through holes device

- Mass pin (E1 to E4 see on drawing page 2): 200 W / 370 °C Iron temperature / 7 mm flat W200 Weller
- ASIC terminals (1,2,3,4 see on drawing page 2): 80 W / 410 °C Iron temperaure / 0.8 mm diameter STTC125 - Metcal

2 - Wave soldering plated-through holes device

LEM recommends to use the following equipment/parameters for the soldering of the HC5F family in order to be compliant with the IPC A-610 (less than 75 % land coverage):

- Machine VITRONICS SOLTEC 6622 in combi wave mode
- Flux SLS 65
- Sn96 lead free solder (SAC 305)
- Temperature profile as below
- PCB 2143-00 - thickness: 1.6 mm - mass pin E1 to E4: hole Ø 2 - Asic pin: hole Ø 1.
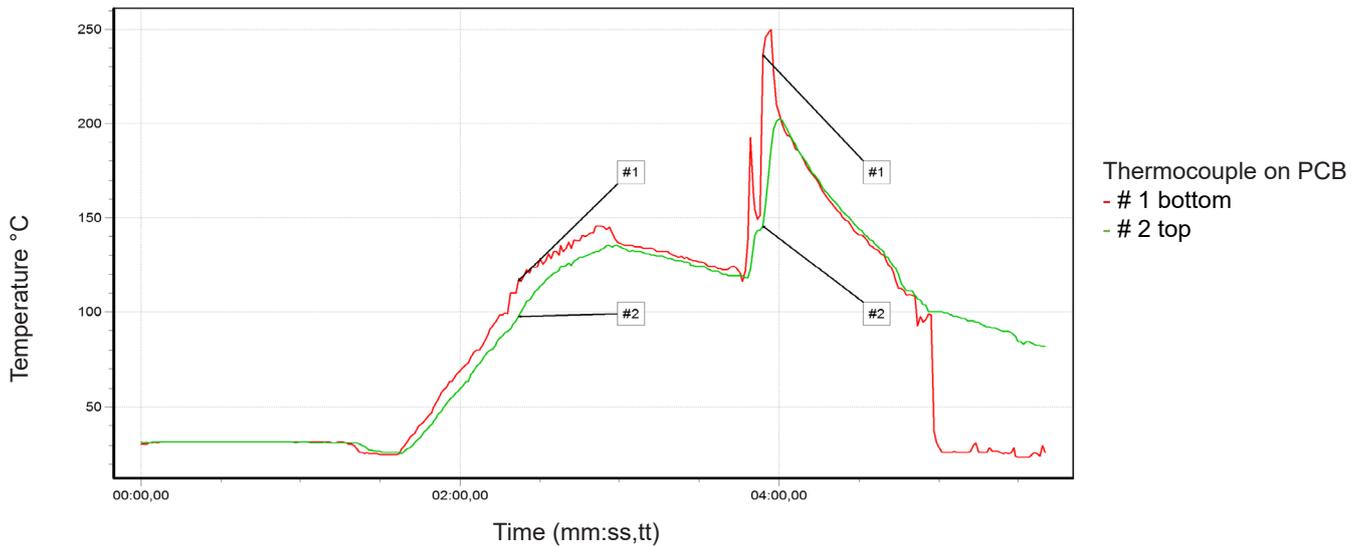
3 - SMD soldering by pin in paste STH (SMD through hole)

- Must be validated by user
- ASIC MSL 1 level.